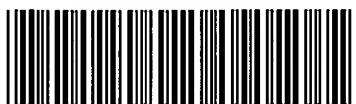


Search Notes**Application/Control No.**

09/543,223

Examiner

Hanh Phan

Applicant(s)/Patent under Reexamination

JACKSON ET AL.

Art Unit

2638

SEARCHED			
Class	Subclass	Date	Examiner
398	135	08/18/05	HP
	128		
	118		
	119		
	124		
	129		
	130		
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	137		
	182		
	202		
	189		
	190		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search see attached printout in the file. iee search, jpo search.	08/18/05	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner